

VERSION (版本) : 01

Customer P/N

SUPPLIER

:

# SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS PRODUCT SPECIFICATION 規格書

CUSTOMER:	DATE:
(客戶): 志盛	鉴翔 (日期):2017-08-22
CATEGORY (品名) DESCRIPTION (型号)	<ul> <li>ALUMINUM ELECTROLYTIC CAPACITORS</li> <li>GT 50V47μF(φ6.3X11)</li> </ul>

SUPPI	JIER	CUST	TOMER
PREPARED (拟定)	CHECKED (审核)	APPROVAL (批准)	SIGNATURE (签名)
李婷	刘渭清		

## ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

		SPECIFICAT	ALTERN	ATION HIS RECORDS	TORY		
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Tab	le 1 Product Dimen	sions a		aracteristic	2 S						Unit: m	m		
	D±0.5				=0.05		F	Shape Code CB Type		D L F H	6.3 11 2.5 3.5			
			Cap.	H±0.5		tan δ	Leakage	Max Ripple Current	Impedance	d	0.5	nensio	n	
N 0.	SAMXON Part No.	WV (Vdc)	(μF )	Cap. tolerance	Temp. range(℃)	(120Hz, 20℃)	Current (µA,2min)	at 105°C 100KHz (mA rms)	at 20°C 100kHz (Ωmax)	lifeti me (Hrs)	D×L	(mm) F	фd	Sleev e
1	EGF476M1HE11CB**P	50	47	-20%~+20%	-40~105	0.10	23.5	295	0.300	5000	6.3X11	2.5	0.5	PET

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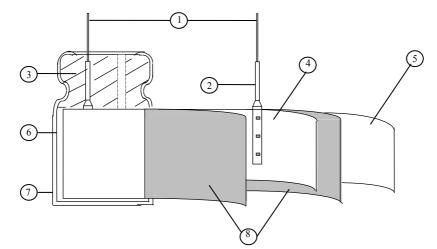
CAPACITANCE         TOL.         VOLTAGE         CASE BIZE         TYPE         DAMACCI:         CLE           erres         0.1         104         ±5         J         2.0         0.0         33.1         1         Formation (1)         100         <		3 4 S 1	5 6 0 5	5 IZ	1	89 1 H	L	10 11 D 1	1			1516 S A	17 P
Cap(MFD)         Code (M-C)         Voltage (MXX)         Code (M-C)         Case Star (M-C)         Feature (M-C)         Code (M-C)         Voltage (MXX)         Code (M-C)         Feature (M-C)         Feature (M-C)         Feature (M-C)         Feature (M-C)         Feature (M-C)         Feature (M-			CITAN		<u>.</u>	VOLTAGE		CASE	SIZE	TYP	E	SAMXON	SLEE
SMM R         0.1         104         ±5         j         2         0.0         Newsense B 3         R         Redai bak         RR           R         0.22         224         ±10         K         63         0.1         106         10         106         10 <td< th=""><th></th><th></th><th>1</th><th>- I</th><th></th><th>1</th><th></th><th></th><th></th><th></th><th></th><th></th><th></th></td<>			1	- I		1							
BMM ECS         0.1         104         ±5         J         22         0.0         Description 100 100         Pacial bulk         RR ECS         Recall bulk         RR ECS         Continue output to poduct times	eries	Cap(MFD)	Code	Tolerance (%)	) Code	Voltage (W.V.)	Code	Case	Size	Feature 0	Code	SAMXON Product	Line
SSS (S)         0.22         224 (S)         100         C         2.50         0.26 (S)         2.50         120         C         2.50         120         C         100	ESM					2	0D	Diameter()	) Code	Radial bulk	RR		
KM         0.33         334         ± 10         K         0.53         000         6.8         0.K         6.8         0.K           CSG         0.47         474         ± 15         L         12.8         10         13         10         2.0mm Pinh         T           CGF         1         105         ± 20         M         20         10         14.6         1.6	ESS				L .			3.5	1	Ammo Tan	ing		
OM         0.33         3.34         ±15         L         10         1A         10         12         2         2         2         2         2         10         1A         10         12         13         14         14         14         14         14         14         14         14         14         14         14         14         14         14         14         14         14         14         14 </td <td></td> <td>0.22</td> <td>224</td> <td>±10</td> <td>  K  </td> <td></td> <td></td> <td>6.3</td> <td>E</td> <td>Anno Iap</td> <td></td> <td></td> <td></td>		0.22	224	±10	K			6.3	E	Anno Iap			
ZZS SGF         0.47         474         D.10         12.5         18         13         1         2.cmm Price         TU           SFF         1         105         ±20         M         20         10         13.5         4         2.cmm Price         10         5.mm Price         TU           SFF         1         105         ±20         M         20         10         14.5         4.7         5.mm Price         TU         5.mm Price		0.33	334					10	F G	2.0mm Pitch	тт		
SF         1         105         ± 20         M         20         DD         14         4	EZS	0.47	474	±15	L			13		2.5mm Pitch	тυ		
Str.         1 <th1< th="">         1         <th1< th=""> <th1< th=""></th1<></th1<></th1<>	ESF	1	105	± 20	м			14		3.5mm Pitch	тν	Sloove Material	Code
2.2         2.23         3.3         3.35         4.0         N         3.22         1.3         18         L	EGK	1	105			25		16	Ŕ				
Singer Ref. Ref. Ref. Ref. Ref. Ref. Ref. Ref.	EGD	2.2	225	±30	N			18	L	5.0mm Pitch	тс	PET	l P
RR         4.7         1.00         2.0         2.0         2.0         2.0         2.0         2.0         2.0         2.0         2.0         2.0         2.0 <td>ERS</td> <td>3.3</td> <td>335</td> <td></td> <td>w</td> <td></td> <td></td> <td>20</td> <td>M</td> <td>Lead Cut &amp; F</td> <td>Form</td> <td>PMC</td> <td>_</td>	ERS	3.3	335		w			20	M	Lead Cut & F	Form	PMC	_
ND         10         106         20         C         37         1L         40         R         37,4         1L         40,4         R           RB         22         226         -710         C         -711         115         -75         11         -75         -75         11         -75         -75         -75         11         -75 <td>ERL</td> <td>47</td> <td>475</td> <td></td> <td></td> <td></td> <td></td> <td>25</td> <td>P</td> <td>СВ-Туре</td> <td>СВ</td> <td>FVC</td> <td>The</td>	ERL	47	475					25	P	СВ-Туре	СВ	FVC	The
ND         10         106         20         C         37         1L         40         R         37,4         1L         40,4         R           RB         22         226         -710         C         -711         115         -75         11         -75         -75         11         -75         -75         -75         11         -75 <td>ERT</td> <td></td> <td></td> <td></td> <td>A  </td> <td></td> <td></td> <td>34 35</td> <td>WQ</td> <td>CE-Type</td> <td>CE</td> <td></td> <td>sleev</td>	ERT				A			34 35	WQ	CE-Type	CE		sleev
RRC FA         33         336         -20 +40         X         75         11 -5         675 -7         T 75         11 -70         675 -70         T 75         KD -70         KD -70         KD           FA         47         476         -20         S         85         1R         90         10         90         2         FD-Type         FD           MH         47         476         -10         B         100         2A         5         56         EH-Type         EH           SRW         100         107         -10         B         126         2B         7.7         77	ERD	10	106		6			40	4	CE-13pe			e ma
RC         33         336         +400         A         80         1K         76         0         RD-1yps         RD           MP         477         476         -20         S         85         1R         80         1K         80         85         1R         80         85         1R         90         100         20         80         85         1R         90         100         20         80         85         1R         90         100         20         20         22         102         20         100         24.5         456         66         67         67         77	EBD	22	226			71	1S	51	6	HE-Type	HE		teria
NP         47         476         +50         S         90         19         100         20         20         20         FD-Type         FD           RWV         100         107         -10         B         100         2A         4.5         45	ERB	33	336		×			76	U	КД-Туре	КD		is P
WY         100         107         -10         B         100         2A         Landrmi Code 5         EH-Type         EH         PCB           UP         220         227         -10         V         150         22         5         05         5         05         7         07         77<	EFA		170		s			90	8 X	FD-Type	FD		/C, #
LP         -         -         -         -         -         5.4         <	ENH	47	476					Len.(mm)	Code				I BIE
1000         220         227         +10         V         150         22         7         07         PCB Termini           330         337         -10         Q         160         22         7         7         77		100	107		в			5	05	EH-Type	EH		≦
HIP         330         337         -10         Q         180         2P         11.5         1A         A           470         477         477         -10         T         200         2D         12.5         18         Snap-in         SX           SP         2200         228         -5         F         215         22         22         Sz         Sz           2200         229         -5         F         2300         23         25         2.0         225         2.0         SG           WW         33000         339         -5         G         310         22R         30         36	EQP	220	227		v			7	07	PCB Term	nial		l lar
HIP         OCC         OCC         OCC         OCC         Had         P	ETP	330	337				_	10.2	T2		sw		i i i i i i i i i i i i i i i i i i i
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$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	EEP	470	477		T			13	1B 13				teen
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$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	EGP	22000	229					29.5	25 2J	Lug	SG		<del>≓</del>
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	EWU	22000	220		F			31.5	3A 35		05	L	
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$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	VKM		0.07		1			150	1R		D5		
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	VNH				z			160	15		D6		
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$		330000	3:3T	+5				170	11				
1500000         15M         +50         Y         600         26         215         2A           1500000         15M         +10         +10         +30         H         630         2J         210         2M           2200000         22M         +30         H         240         2Q         2N           250         225         250         2S         250         2S		1000000	10M					190 200	1V 2L				
+10         +220         2N           2200000         22M         240         220           250         2R         250         2S		1500000	15M	+50	×			215 210	2A 2M				
2200000 22M 250 2R 260 2S					н			220	2N 2Q				
		2200000	22M					250 260	2R 2S				

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#### 3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



	Component	Material
1	Lead line	Tinned CP wire (Pb Free)
2	Terminal	Aluminum wire
3	Sealing Material	Rubber
4	Al-Foil (+)	Formed aluminum foil
5	Al-Foil (-)	Etched aluminum foil or formed aluminum foil
6	Case	Aluminum case
7	Sleeve	РЕТ
8	Separator	Electrolyte paper

## 4. Characteristics

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

Ambient temperature	:15°C to 35°C
Relative humidity	: 45% to 85%
Air Pressure	: 86kPa to 106kPa

If there is any doubt about the results, measurement shall be made within the following conditions:

Ambient temperature	$: 20^{\circ}C \pm 2^{\circ}C$
Relative humidity	: 60% to 70%
Air Pressure	: 86kPa to 106kPa

#### Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

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	ITEM				PERFO	RMANC	СЕ			
	Rated voltage									
	(WV)	WV (V.DC)	6.3	10	16	25	35	50	63	100
4.1		SV (V.DC)	8	13	20	32	44	63	79	125
	Surge voltage (SV)			·						
4.2	Nominal capacitance (Tolerance)	Condition> Measuring Fri Measuring Vo Measuring Tri <criteria> Shall be withing</criteria>	oltage emperat	: N ure : 20	)±2℃	han 0.5V				
1.3	Leakage current	<condition> Connecting the minutes, and the Criteria&gt; Refer to Table</condition>	then, me		-		istor (1	k Ω ± 10	$(\Omega)$ in s	eries for
4.4	tan δ	<condition> See 4.2, Norr <criteria> Refer to Table</criteria></condition>	-	itance, fo	or measur	ing frequ	iency, vo	oltage and	l tempera	ature.
		Condition> Tensile Stree Fixed the c seconds. Bending Str Fixed the ca 90° within 2 seconds.	ength of apacitor ength of pacitor, ~3 seco	r, applied f Termina applied f onds, and	force to ils. orce to b then ber	ent the te	rminal ( 0° to its	1∼4 mm f	from the position	rubber) f
4.5	Terminal					(kgf)		(kg	gf)	
	strength	0.5n Over 0.5	nm and l			5 (0.51) 0 (1.0)		2.5 (		
		<criteria< td=""><td>1&gt;</td><td>nanges sh</td><td></td><td></td><td>reakage</td><td>X</td><td>.51) ess at the</td><td>e termina</td></criteria<>	1>	nanges sh			reakage	X	.51) ess at the	e termina

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		<conditi< th=""><th></th><th></th><th></th><th></th><th></th><th></th><th></th><th></th></conditi<>								
		S	TEP Testi	ng Tempe	rature(°C)			Time		
			1	$20\pm 2$	2	Time	to reach	thermal of	equilibri	um
			2 -40(-25)		$\pm 3$	Time	Time to reach thermal equilibrium			um
			3	$20\pm 2$	2	Time	Time to reach thermal equilibrium			um
			4	$105\pm$	2	Time	to reach	thermal e	equilibri	um
			5	$20\pm 2$	2	Time	to reach	thermal of	equilibri	um
		<criteria< td=""><td>a&gt;</td><td></td><td></td><td></td><td></td><td></td><td></td><td></td></criteria<>	a>							
			shall be with			4.4The le	eakage cu	urrent me	easured s	hall not
	Temperature		in 8 times of i	-			4 4 771			
	characteristi		ep 5, tan $\delta$ sha		nin the lim	it of Iter	n 4.4The	leakage	current	shall no
4.6	cs		in the specifie $0^{\circ}$ C (-25 °C), in		$(\pi)$ ratio	hall not	waaad th		of the fol	lowing
		table.	) C (-25 C), II	Inpedance	(Z) 18110 S	man not e		le value (	of the for	llowing
			Voltage (V)	6.3	10	16	25	35	50	63
		-	C/Z+20°C	5	4	3	2	2	2	2
		Z-40°C	C/Z+20℃	10	8	6	4	3	3	3
		Westing	$\mathbf{V}_{2}$	100	1					
			Voltage (V) $C/Z+20^{\circ}C$	100 2						
			$Z/Z+20^{\circ}C$	3						
			citance value	-	] E Add 0 4	ner ano	ther 1000	) 11 E for	7_25/7+	20°C
		1 of capa	citance value							
				> 1000 µ		-				
		Capacitan	ice, tan $\delta$ , and		Add 1.0	per anot	her 1000	μ F for 2		
		<conditi< td=""><td>ice, tan <math>\delta</math> , and <b>ion</b>&gt;</td><td>d impedan</td><td>Add 1.0 nce shall b</td><td>e measur</td><td>her 1000 ed at 120</td><td>)µF for 2 )Hz.</td><td>Z-40°C/2</td><td>Z+20℃.</td></conditi<>	ice, tan $\delta$ , and <b>ion</b> >	d impedan	Add 1.0 nce shall b	e measur	her 1000 ed at 120	)µF for 2 )Hz.	Z-40°C/2	Z+20℃.
		<conditi Accordin</conditi 	ice, tan $\delta$ , and ion> ig to IEC6038	d impedan 34-4No.4.	Add 1.0 nce shall b	e measur s, The ca	her 1000 ed at 120 pacitor is	) µ F for 2 )Hz. s stored a	Z-40°C/Z	Z+20°C.
		<b>Conditi</b> Accordin 105°C ±	ice, tan $\delta$ , and ion> ig to IEC6038 2 with DC bi	d impedan 34-4No.4. as voltage	Add 1.0 nce shall b 13 method e plus the r	b per anot e measur s, The ca ated ripp	her 1000 ed at 120 pacitor is le curren	) µ F for 2 )Hz. s stored a t for Tab	Z-40°C/Z	Z+20°C. erature of he sum of
		<conditi Accordin 105°C ± DC and</conditi 	ice, tan $\delta$ , and ion> ig to IEC6038 2 with DC bi ripple peak	d impedan 34-4No.4. as voltage voltage sh	Add 1.0 nee shall b 13 method e plus the r nall not ex	s, The ca ated ripp	her 1000 ed at 120 pacitor is le curren e rated w	) μ F for 2 DHz. s stored a t for Tab yorking y	Z-40°C/Z at a temp ble 1. (T voltage)	Z+20°C. erature of he sum of Then th
	Land	Condition According 105°C ± DC and product s	tion $\delta$ , and ion $\delta$ ing to IEC6038 2 with DC bi ripple peak $\delta$ should be test	d impedan 34-4No.4. as voltage voltage sh ed after 16	Add 1.0 nce shall b 13 method e plus the r nall not ex 6 hours rec	s, The ca ated ripp	her 1000 ed at 120 pacitor is le curren e rated w	) μ F for 2 DHz. s stored a t for Tab yorking y	Z-40°C/Z at a temp ble 1. (T voltage)	Z+20°C. erature of he sum of Then th
47	Load	Condition According 105°C ± DC and product s	ice, tan $\delta$ , and ion> ig to IEC6038 2 with DC bi ripple peak should be test ould meet the	d impedan 34-4No.4. as voltage voltage sh ed after 16	Add 1.0 nce shall b 13 method e plus the r nall not ex 6 hours rec	s, The ca ated ripp	her 1000 ed at 120 pacitor is le curren e rated w	) μ F for 2 DHz. s stored a t for Tab yorking y	Z-40°C/Z at a temp ble 1. (T voltage)	Z+20°C. erature of he sum of Then th
4.7	Load life test	Conditi Accordin 105°C ± DC and product s result sho <criteri< p=""></criteri<>	ice, tan $\delta$ , and ion> ig to IEC6038 2 with DC bi ripple peak should be test ould meet the	d impedan 34-4No.4. as voltage voltage sh ed after 16 following	Add 1.0 nce shall b 13 method e plus the r nall not ex 6 hours rec g table: e followin	s, The ca ated ripp cceed the covering t	her 1000 ed at 120 pacitor is le curren e rated w ime at at ments.	) µ F for 2 DHz. s stored a t for Tab yorking v mospher	Z-40°C/Z at a temp ble 1. (T voltage)	Z+20°C. erature of he sum of Then th
4.7	life	Condition According 105°C ± DC and product so result shot control of the chart o	ince, $\tan \delta$ , and ion> ing to IEC6038 2 with DC bis ripple peak should be test ould meet the ia>	d impedan 34-4No.4. as voltage voltage sh ed after 16 following <u>ll meet th</u>	Add 1.0 ace shall b 13 method e plus the r hall not ex 6 hours rec g table:	s, The ca ated ripp cceed the covering t	her 1000 ed at 120 pacitor is le curren e rated w ime at at ments.	) µ F for 2 DHz. s stored a t for Tab yorking v mospher	Z-40°C/Z at a temp ble 1. (T voltage)	Z+20°C. erature of he sum of Then th
4.7	life	Condition According 105°C ± DC and product s result show contract the chart The chart Let the chart the	ice, tan $\delta$ , and ion> ig to IEC6038 2 with DC bi ripple peak should be test ould meet the ia> racteristic sha	d impedan 34-4No.4. as voltage voltage sh ed after 16 following <u>ll meet th</u>	Add 1.0 nce shall b 13 method e plus the r nall not ex 6 hours rec g table: e followin	b per anot e measur s, The ca ated ripp ated ripp cceed the covering g require 4.3 shall	her 1000 ed at 120 pacitor is le curren e rated w time at at <u>ments.</u> be satisfi	) μ F for 2 DHz. s stored a t for Tab zorking v mospher	Z-40°C/Z at a temp ble 1. (T voltage)	Z+20°C. erature of he sum of Then th
4.7	life	Condition According 105°C ± DC and product s result shot  Critering The charactering Caractering Caracte	ice, tan $\delta$ , and ion> ig to IEC6038 c2 with DC bi ripple peak should be test ould meet the ia> racteristic sha eakage curren	d impedan 34-4No.4. as voltage voltage sh ed after 16 following <u>ll meet th</u>	Add 1.0 nce shall b 13 method e plus the r nall not ex 5 hours rec g table: e followin Value in	b per anot e measur s, The ca ated ripp acceed the covering to g require 4.3 shall 225% of	her 1000 ed at 120 pacitor is le curren rated w ime at at ments. be satisfi initial va	) µ F for 2 DHz. s stored æ t for Tab vorking v mospher ied alue.	Z-40°C/Z at a temp ble 1. (T voltage) ic condit	Z+20°C. erature of he sum of Then the tions. The
4.7	life	Condition Accordinal 105°C ± DC and product s result shot <criterian The char</criterian 	ince, $\tan \delta$ , and ion> ing to IEC6038 2 with DC bis ripple peak should be test ould meet the ia> racteristic shat eakage current apacitance Ch	d impedan 34-4No.4. as voltage voltage sh ed after 16 following <u>ll meet th</u>	Add 1.0 ace shall b 13 method e plus the r hall not ex 6 hours rec g table: e followin Value in Within <u>+</u>	b per anot e measur s, The ca ated ripp cceed the covering t g require 4.3 shall 25% of than 200	her 1000 ed at 120 pacitor is le curren e rated w ime at at ments. be satisfi initial va 0% of the	) μ F for 2 DHz. s stored a t for Tab vorking v mospher ied alue. e specifie	Z-40°C/Z at a temp ble 1. (T voltage) ic condit	Z+20°C. erature of he sum of Then the tions. The
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4.7	life test Shelf life	<conditi< th=""><math>Accordin<math>105^{\circ}C \pm</math>DC andproduct sresult shot<criteri< td="">The charLeeCatanAppliedConditiThe capaci<math>1000+48</math>chambershall be applied for</criteri<></math></conditi<>	ace, tan $\delta$ , and ion> ing to IEC6038 2 with DC bi- ripple peak v should be test ould meet the ia> racteristic sha eakage curren apacitance Ch n $\delta$ ppearance tion> itors are then /0 hours. Foll and be allow connected to for 30min. Aft	d impedan 34-4No.4. as voltage voltage sh ed after 16 following 11 meet the t nange stored wi lowing thi ved to stal a series	Add 1.0 ace shall b 13 method e plus the r hall not ex 6 hours rec g table: e followin Value in Within <u>±</u> Not more There sha th no volta is period th bilized at limiting rec	e measur e measur ated ripp acceed the covering to g require 4.3 shall 25% of all be no age applic ne capaci room ten esistor(1k	her 1000 ed at 120 pacitor is le curren rated w ime at at ments. be satisfi initial va 0% of the leakage of ed at a te tors shal perature $\pm 100 \Omega$	<ul> <li>μ F for 2</li> <li>s stored a</li> <li>t for Tab</li> <li>y orking way of the store of the stor</li></ul>	z-40°C/2 at a temp ble 1. (T voltage) ic condit ic condit d value. hyte. re of 105 oved from D.C. rate	$\pm 2^{\circ}C$ for mathematical formula for the sum of the
	life test Shelf	<conditi< th=""><math>Accordin<math>105^{\circ}C \pm</math>DC andproduct sresult shot<criteri< td="">The charLeeCataiApproximation<condition< td="">The capaci<math>1000+48</math>chambershall be observed</condition<></criteri<></math></conditi<>	ace, tan $\delta$ , and ion> ing to IEC6038 2 with DC bi- ripple peak v should be test ould meet the ia> racteristic sha eakage curren apacitance Ch n $\delta$ ppearance tion> itors are then /0 hours. Foll and be allow connected to for 30min. Aft	d impedan 34-4No.4. as voltage voltage sh ed after 16 following 11 meet the t nange stored wi lowing thi ved to stal a series	Add 1.0 ace shall b 13 method e plus the r hall not ex 6 hours rec g table: e followin Value in Within <u>±</u> Not more There sha th no volta is period th bilized at limiting rec	e measur e measur ated ripp acceed the covering to g require 4.3 shall 25% of all be no age applic ne capaci room ten esistor(1k	her 1000 ed at 120 pacitor is le curren rated w ime at at ments. be satisfi initial va 0% of the leakage of ed at a te tors shal perature $\pm 100 \Omega$	<ul> <li>μ F for 2</li> <li>s stored a</li> <li>t for Tab</li> <li>y orking way of the store of the stor</li></ul>	z-40°C/2 at a temp ble 1. (T voltage) ic condit ic condit d value. hyte. re of 105 oved from D.C. rate	$\pm 2^{\circ}C$ for mathematical formula for the sum of the
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		<criteria></criteria>
		The characteristic shall meet the following requirements.
		Leakage current Value in 4.3 shall be satisfied
	Shelf	Capacitance Change Within $\pm 25\%$ of initial value.
4.8	life	tan $\delta$ Not more than 200% of the specified value.
	test	Appearance There shall be no leakage of electrolyte.
		Remark: If the capacitors are stored more than 1 year, the leakage current may
		increase. Please apply voltage through about 1 k $\Omega$ resistor, if necessary.
4.9	Surge test	<condition>Applied a surge voltage to the capacitor connected with a <math>(100 \pm 50)/C_R (k\Omega)</math> resistor. The capacitor shall be submitted to 1000 cycles, each consisting of charge of <math>30 \pm 5s</math>, followed discharge of 5 min 30s. The test temperature shall be <math>15\sim35^{\circ}C</math>. <math>C_R</math> :Nominal Capacitance (<math>\mu</math> F)<criteria>Capacitance ChangeWithin <math>\pm 15\%</math> of initial value. AppearanceAppearanceThere shall be no leakage of electrolyte.Attention: This test simulates over voltage at abnormal situation only. It is not applicable to such over voltage as often applied.</criteria></br></condition>
		over voltage as often applied.
4.10	Vibration test	<condition>The following conditions shall be applied for 2 hours in each 3 mutually perpendicular directions.Wibration frequency range: 10Hz ~ 55Hz Peak to peak amplitudePeak to peak amplitude: 1.5mm Sweep rateSweep rate: 10Hz ~ 55Hz ~ 10Hz in about 1 minuteMounting method:The capacitor with diameter greater than 12.5mm or longer than 25mm must be fixed in place with a bracket.<math>4mm</math> or less <math>4mm</math> or less To be solderedAfter the test, the following items shall be tested:Inner constructionNo intermittent contacts, open or short circuiting. No damage of tab terminals or electrodes. The markings shall be legible.</br></condition>

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## ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES



		<condition> The capacitor shall be tested up</condition>	nder the following	conditions:			
		Soldering temperature	: 245±3°C				
		Dipping depth : 2mm					
4.11 Solderability test	Dipping speed : 25±2.5mm/s						
	Dipping time : 3±0.5s <criteria></criteria>						
			A minimur	n of 95% of the surface	being		
		Coating quality	immersed				
		<condition></condition>	11 h . :		5°Cf==10		
		Terminals of the capacitor shall					
		1 seconds or $400 \pm 10^{\circ}$ C for $3^{+1}_{-0}$					
4.12 Resistance to solder heat test	<b>D</b>	Then the capacitor shall be left for 1~2 hours before measuren		temperature and norma	l humidity		
	< <u>Criteria&gt;</u>	iciit.					
	Leakage current	Not more than t	he specified value.				
		Capacitance Change	Within $\pm 10\%$ c	of initial value.			
		tan δ	Not more than t	he specified value.			
		Appearance	There shall be n	o leakage of electrolyte	e.		
		<condition></condition>					
		Temperature Cycle:According			shall be		
		placed in an oven, the conditio	-	Time			
		Temper (1)+20℃	lature	$\leq 3$ Minutes			
		(1)+20 C (2)Rated low temperature	$(40^{\circ}C)(25^{\circ}C)$	$30\pm 2$ Minutes			
	Change of			$30\pm 2$ Minutes $30\pm 2$ Minutes			
4.13	temperature test	(3)Rated high temperature (1) to (2)=1 cucle, total 5		$30\pm 2$ Willines			
	test	(1) to (3)=1 cycle, total 5 ( <b>Criteria</b> >	cycle				
		The characteristic shall meet th	e following require	ement			
			Not more than the s		]		
		tan δ	Not more than the s	ot more than the specified value.			
		Appearance	There shall be no le	eakage of electrolyte.	]		
		<b><condition></condition></b> Humidity Test:					
		According to IEC60384-4No.4	12 methods capa	citor shall be exposed f	for $500 \pm 8$		
		hours in an atmosphere of 90~	· •	•			
		meet the following requirement		,	U		
		<criteria></criteria>			I		
4.14	Damp heat		more than the spe				
	test	1 0	$\frac{1}{20\%}$ of initiation $\frac{1}{20\%}$	al value. of the specified value.			
			re shall be no leak	•			
					l		

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#### ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES



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# 5. It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-QA-072).

	Substances					
	Cadmium and cadmium compounds					
Heavy metals	Lead and lead compounds					
fieuv y filetais	Mercury and mercury compounds					
	Hexavalent chromium compounds					
	Polychlorinated biphenyls (PCB)					
Chloinated	Polychlorinated naphthalenes (PCN)					
organic	Polychlorinated terphenyls (PCT)					
compounds	Short-chain chlorinated paraffins(SCCP)					
	Other chlorinated organic compounds					
D · (1	Polybrominated biphenyls (PBB)					
Brominated	Polybrominated diphenylethers(PBDE) (including					
organic	decabromodiphenyl ether[DecaBDE])					
compounds	Other brominated organic compounds					
Tributyltin comp	pounds(TBT)					
Triphenyltin con	npounds(TPT)					
Asbestos						
Specific azo con	npounds					
Formaldehyde						
Beryllium oxide						
Beryllium copp	ber					
Specific phthalat	tes (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP)					
Hydrofluorocarb	oon (HFC), Perfluorocarbon (PFC)					
Perfluorooctane	sulfonates (PFOS)					
Specific Benzoti	riazole					

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#### **Attachment: Application Guidelines**

#### 1.Circuit Design

- 1.1 Operating Temperature and Frequency
  - Electrolytic capacitor electrical parameters are normally specified at 20°C temperature and 120Hz frequency. These parameters vary with changes in temperature and frequency. Circuit designers should take these changes into consideration.
- (1) Effects of operating temperature on electrical parameters
   a) At higher temperatures, leakage current and capacitance increase while equivalent series resistance (ESR) decreases.
   b) At lower temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) increases.
- (2) Effects of frequency on electrical parameters
  - a) At higher frequencies capacitance and impedance decrease while tanδ increases.
  - b) At lower frequencies, ripple current generated heat will rise due to an increase in equivalent series resistance (ESR).
- 1.2 Operating Temperature and Life Expectancy

See the file: Life calculation of aluminum electrolytic capacitor

1.3 Common Application Conditions to Avoid

The following misapplication load conditions will cause rapid deterioration to capacitor electrical parameters. In addition, rapid heating and gas generation within the capacitor can occur causing the pressure relief vent to operate and resultant leakage of electrolyte. Under Leaking electrolyte is combustible and electrically conductive.

#### (1) Reverse Voltage

DC capacitors have polarity. Verify correct polarity before insertion. For circuits with changing or uncertain polarity, use DC bipolar capacitors. DC bipolar capacitors are not suitable for use in AC circuits.

(2) Charge / Discharge Applications

Standard capacitors are not suitable for use in repeating charge / discharge applications. For charge / discharge applications consult us and advise actual conditions.

(3) Over voltage

Do not apply voltages exceeding the maximum specified rated voltage. Voltages up to the surge voltage rating are acceptable for short periods of time. Ensure that the sum of the DC voltage and the superimposed AC ripple voltage does not exceed the rated voltage.

(4) Ripple Current

Do not apply ripple currents exceeding the maximum specified value. For high ripple current applications, use a capacitor designed for high ripple currents or contact us with your requirements. Ensure that allowable ripple currents superimposed on low DC bias voltages do not cause reverse voltage conditions.

- 1.4 Using Two or More Capacitors in Series or Parallel
- (1) Capacitors Connected in Parallel

The circuit resistance can closely approximate the series resistance of the capacitor causing an imbalance of ripple current loads within the capacitors. Careful design of wiring methods can minimize the possibility of excessive ripple currents applied to a capacitor.

(2) Capacitors Connected in Series

Normal DC leakage current differences among capacitors can cause voltage imbalances. The use of voltage divider shunt resistors with consideration to leakage current can prevent capacitor voltage imbalances.

#### 1.5 Capacitor Mounting Considerations

(1) Double Sided Circuit Boards

Avoid wiring pattern runs, which pass between the mounted capacitor and the circuit board.

When dipping into a solder bath, excess solder may collect under the capacitor by capillary action and short circuit the anode and cathode terminals.

(2)Circuit Board Hole Positioning

The vinyl sleeve of the capacitor can be damaged if solder passes through a lead hole for subsequently processed parts. Special care when locating hole positions in proximity to capacitors is recommended.

(3)Circuit Board Hole Spacing

The circuit board holes spacing should match the capacitor lead wire spacing within the specified tolerances. Incorrect spacing can cause excessive lead wire stress during the insertion process. This may result in premature capacitor failure due to short or open circuit, increased leakage current, or electrolyte leakage.

(4) Clearance for Case Mounted Pressure Relief vents

Capacitors with case mounted pressure relief vents require sufficient clearance to allow for proper vent operation. The minimum clearances are dependent on capacitor diameters as proper vent operation. The minimum clearances are dependent on capacitor diameters as follows.

φ6.3~φ16mm:2mm minimum, φ18~φ35mm:3mm minimum, φ40mm or greater:5mm minimum.

(5) Clearance for Seal Mounted Pressure Relief Vents

A hole in the circuit board directly under the seal vent location is required to allow proper release of pressure.

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(6) Wiring Near the Pressure Relief Vent Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100°C may be released which could dissolve the wire insulation and ignite. (7) Circuit Board patterns Under the Capacitor Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short. (8) Screw Terminal Capacitor Mounting Do not orient the capacitor with the screw terminal side of the capacitor facing downwards. Tighten the terminal and mounting bracket screws within the torque range specified in the specification. 1.6 Electrical Isolation of the Capacitor Completely isolate the capacitor as follows. (1) Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths (2) Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths. 1.7 The Product endurance should take the sample as the standard. 1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling. 1.9 Capacitor Sleeve The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor. The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures. CAUTION! Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use. (1) Provide protection circuits and protection devices to allow safe failure modes. (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure. 2.Capacitor Handling Techniques 2.1 Considerations Before Using (1) Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment. (2) Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about  $1k\Omega$ . (3) Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately  $1k\Omega$ . (4) If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors. (5) Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result. 2.2 Capacitor Insertion (1) Verify the correct capacitance and rated voltage of the capacitor. (2) Verify the correct polarity of the capacitor before inserting. (3) Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals. (4) Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor. For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection. 2.3 Manual Soldering (1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less. (2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal. (3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads. (4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve. 2.4 Flow Soldering (1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result. (2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits.

- (3) Do not allow other parts or components to touch the capacitor during soldering.
- 2.5 Other Soldering Considerations

Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

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- 2.6 Capacitor Handling after Solder
- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.
- 2.7 Circuit Board Cleaning

Acetone

- Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60°C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

- Alkali solvents : could attack and dissolve the aluminum case.
- Petroleum based solvents: deterioration of the rubber seal could result.
- Xylene : deterioration of the rubber seal could result.
  - : removal of the ink markings on the vinyl sleeve could result.
- (3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.
- (4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.
- 2.8 Mounting Adhesives and Coating Agents
  - When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

#### 3. Precautions for using capacitors

- 3.1 Environmental Conditions
  - Capacitors should not be stored or used in the following environments.
- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

3.2 Electrical Precautions

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

#### 4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.
- (2) Avoid contact with the escaping electrolyte gas which can exceed 100°C temperatures. If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.
- If electrolyte or gas is ingested by month, gargle with water.
  - If electrolyte of gas is ingested by month, gargie with water.

#### 5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a 1000 $\Omega$ , current limiting resistor for a time period of 30 minutes. If the expired date of products date code is over eighteen months, the products should be return to confirmation.

5.1 Environmental Conditions

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The capacitor shall be not use in the following condition:

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

#### 6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise). Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE: Local laws may have specific disposal requirements, which must be followed.